$\overline{}$	Substitute for fo	orm 1449 <i>F</i>	A/PTO		Complete if Known
INEO	DMATION	ו חופו	CLOSURE	Application No.	10/814,052
			PPLICANT	Filing Date	March 31, 2004
SIAI		эт Аг	PLICANT	First Named Inventor	David Benjamin Auerbach
				Art Unit	2165
				Examiner Name	Michael J. Hicks
Sheet	1	of	4	Attorney Docket Number	24207-10107

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